

Tiny 1.5A, High-Speed Power MOSFET Driver

Features

- High Peak Output Current: 1.5A (typical)
- Wide Input Supply Voltage Operating Range:
 - 4.5V to 18V
- Low Shoot-Through/Cross-Conduction Current in Output Stage
- · High Capacitive Load Drive Capability:
 - 470 pF in 13 ns (typical)
 - 1000 pF in 20 ns (typical)
- Short Delay Times: 41 ns (t_{D1}), 48 ns (t_{D2}) (typical)
- Low Supply Current:
 - With Logic '1' Input 0.65 mA (typical)
 - With Logic '0' Input 0.1 mA (typical)
- Latch-Up Protected: Will Withstand 500 mA Reverse Current
- Logic Input Will Withstand Negative Swing Up To 5V
- · Space-saving 5L SOT-23 Package

Applications

- Switch Mode Power Supplies
- · Pulse Transformer Drive
- · Line Drivers
- Level Translator
- · Motor and Solenoid Drive

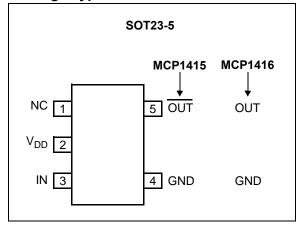
General Description

The MCP1415/16 are high speed MOSFET drivers capable of providing 1.5A of peak current. The inverting or non-inverting single channel output is directly controlled from either TTL or CMOS (3V to 18V) logic. These devices also feature low shoot-through current, matched rise and fall time, and short propagation delays which make them ideal for high switching frequency applications.

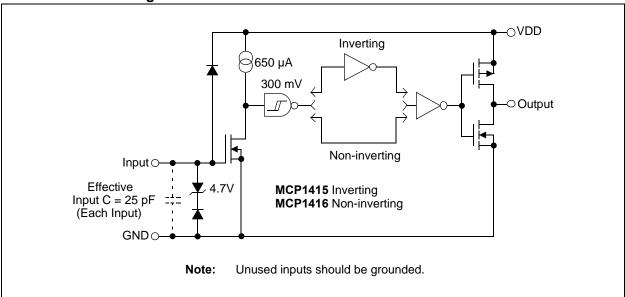
The MCP1415/16 devices operate from a single 4.5V to 18V power supply and can easily charge and discharge 1000 pF gate capacitance in under 20 ns (typical). They provide low enough impedances in both the on and off states to ensure the intended state of the MOSFET will not be affected, even by large transients.

These devices are highly latch-up resistant under any condition within their power and voltage ratings. They are not subject to damage when up to 5V of noise spiking (of either polarity) occurs on the ground pin. They can accept, without damage or logic upset, up to 500 mA of reverse current being forced back into their outputs. All terminals are fully protected against Electrostatic Discharge (ESD) up to 2.0 kV (HBM) and 400V (MM).

Package Type:



Functional Block Diagram



1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings †

† **Notice:** Stresses above those listed under "Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at those or any other conditions above those indicated in the operational sections of this specification is not intended. Exposure to maximum rating conditions for extended periods may affect device reliability.

DC CHARACTERISTICS

Parameters	Sym	Min	Тур	Max	Units	Conditions	
Input	•					<u> </u>	
Logic '1' High Input Voltage	V _{IH}	2.4	1.9	_	V		
Logic '0' Low Input Voltage	V _{IL}	_	1.6	0.8	V		
Input Current	I _{IN}	-1	_	+1	μA	$0V \le V_{IN} \le V_{DD}$	
Input Voltage	V _{IN}	-5	_	V _{DD} +0.3	V		
Output		•					
High Output Voltage	V _{OH}	V _{DD} - 0.025	_	_	V	DC Test	
Low Output Voltage	V _{OL}	_	_	0.025	V	DC Test	
Output Resistance, High	R _{OH}	_	6	7.5	Ω	I _{OUT} = 10 mA, V _{DD} = 18V (Note 2)	
Output Resistance, Low	R _{OL}	_	4	5.5	Ω	I _{OUT} = 10 mA, V _{DD} = 18V (Note 2)	
Peak Output Current	I _{PK}	_	1.5	_	Α	V _{DD} = 18V (Note 2)	
Latch-Up Protection Withstand Reverse Current	I _{REV}	0.5	_	_	Α	Duty cycle \leq 2%, t \leq 300 μ S	
Switching Time (Note 1)	•						
Rise Time	t _R	_	20	25	ns	Figure 4-1, Figure 4-2 C _L = 1000 pF (Note 2)	
Fall Time	t _F	_	20	25	ns	Figure 4-1, Figure 4-2 C ₁ = 1000 pF (Note 2)	
Delay Time	t _{D1}	_	41	50	ns	Figure 4-1, Figure 4-2 (Note 2)	
Delay Time	t _{D2}	_	48	55	ns	Figure 4-1, Figure 4-2 (Note 2)	
Power Supply							
Supply Voltage	V_{DD}	4.5	_	18	V		
Dawar Cupply Current	Is	_	0.65	1.1	mA	$V_{IN} = 3V$	
Power Supply Current	Is	_	0.1	0.15	mA	V _{IN} = 0V	

Note 1: Switching times ensured by design.

2: Tested during characterization, not production tested.

DC CHARACTERISTICS (OVER OPERATING TEMPERATURE RANGE)

Electrical Specifications: Unless otherwise indicated, over operating range with $4.5 \text{V} \le \text{V}_{DD} \le 18 \text{V}$.									
Parameters	Sym	Min	Тур	Max	Units	Conditions			
Input									
Logic '1', High Input Voltage	V _{IH}	2.4	_	_	V				
Logic '0', Low Input Voltage	V _{IL}	_		0.8	V				
Input Current	I _{IN}	-10	_	+10	μA	$0V \le V_{IN} \le V_{DD}$			
Input Voltage	V _{IN}	-5		V _{DD} +0.3	V				
Output									
High Output Voltage	V _{OH}	V _{DD} - 0.025	_	_	V	DC Test			
Low Output Voltage	V _{OL}			0.025	V	DC Test			
Output Resistance, High	R _{OH}		8.5	9.5	Ω	I _{OUT} = 10 mA, V _{DD} = 18V (Note 2)			
Output Resistance, Low	R _{OL}	_	6	7	Ω	I _{OUT} = 10 mA, V _{DD} = 18V (Note 2)			
Switching Time (Note 1)									
Rise Time	t _R	_	30	40	ns	Figure 4-1, Figure 4-2 C _L = 1000 pF (Note 2)			
Fall Time	t _F	_	30	40	ns	Figure 4-1, Figure 4-2 C _L = 1000 pF (Note 2)			
Delay Time	t _{D1}		45	55	ns	Figure 4-1, Figure 4-2 (Note 2)			
Delay Time	t _{D2}	_	50	60		Figure 4-1, Figure 4-2 (Note 2)			
Power Supply									
Supply Voltage	V_{DD}	4.5	_	18	V				
Power Supply Current	I _S	<u> </u>	0.75	1.5	mA	V _{IN} = 3.0V			
Power Supply Current	I _S	_	0.15	0.25	mA	$V_{IN} = 0V$			

Note 1: Switching times ensured by design.

TEMPERATURE CHARACTERISTICS

Electrical Specifications: Unless otherwise noted, all parameters apply with $4.5 \text{V} \leq \text{V}_{DD} \leq 18 \text{V}$								
Parameter	Sym	Min	Тур	Max	Units	Comments		
Temperature Ranges								
Specified Temperature Range	T _A	-40	_	+125	°C			
Maximum Junction Temperature	TJ	_	_	+150	°C			
Storage Temperature Range	T _A	-65	_	+150	°C			
Package Thermal Resistances								
Thermal Resistance, 5LD SOT23	θ_{JA}	_	256	_	°C/W			

^{2:} Tested during characterization, not production tested.

2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

Note: Unless otherwise indicated, $T_A = +25^{\circ}C$ with $4.5V \le V_{DD} \le = 18V$.

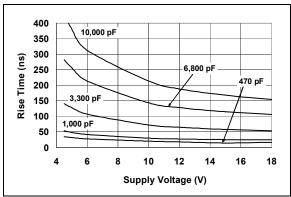


FIGURE 2-1: Rise Time vs. Supply Voltage.

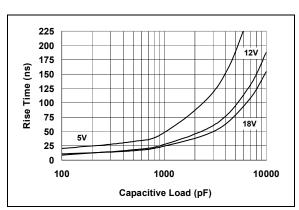


FIGURE 2-2: Rise Time vs. Capacitive Load.

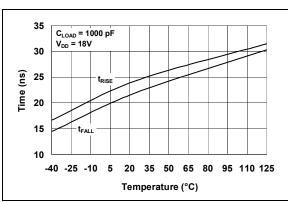


FIGURE 2-3: Rise and Fall Times vs. Temperature.

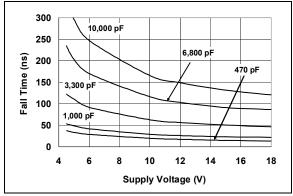


FIGURE 2-4: Fall Time vs. Supply Voltage.

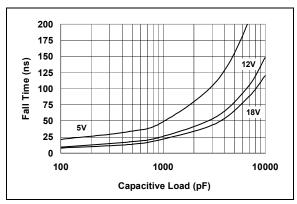


FIGURE 2-5: Fall Time vs. Capacitive Load.

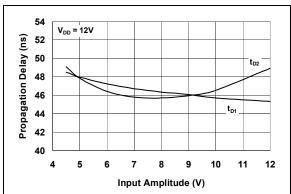


FIGURE 2-6: Propagation Delay Time vs. Input Amplitude.

Typical Performance Curves (Continued)

Note: Unless otherwise indicated, $T_A = +25^{\circ}C$ with $4.5V \le V_{DD} \le = 18V$.

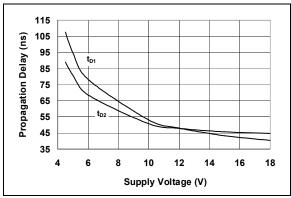


FIGURE 2-7: Supply Voltage.

Propagation Delay Time vs.

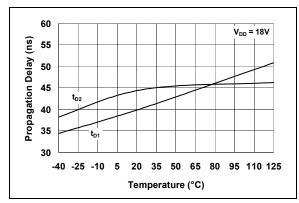


FIGURE 2-8: Temperature.

Propagation Delay Time vs.

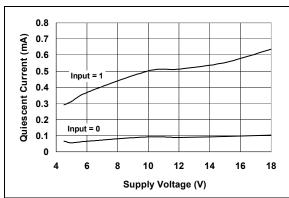


FIGURE 2-9: Supply Voltage.

Quiescent Current vs.

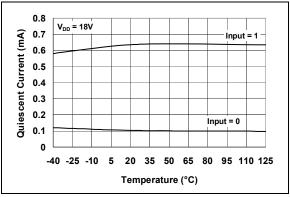


FIGURE 2-10: Temperature.

Quiescent Current vs.

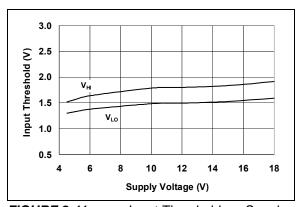


FIGURE 2-11: Voltage.

Input Threshold vs. Supply

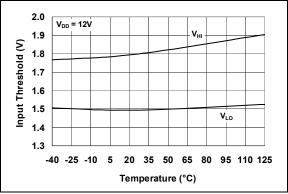


FIGURE 2-12:

Input Threshold vs.

Temperature.

Typical Performance Curves (Continued)

Note: Unless otherwise indicated, $T_A = +25^{\circ}C$ with $4.5V \le V_{DD} \le = 18V$.

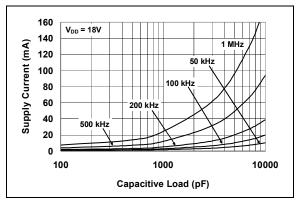


FIGURE 2-13: Supply Current vs. Capacitive Load.

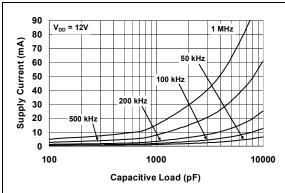


FIGURE 2-14: Supply Current vs. Capacitive Load.

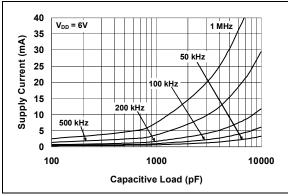


FIGURE 2-15: Supply Current vs. Capacitive Load.

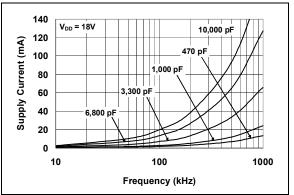


FIGURE 2-16: Supply Current vs. Frequency.

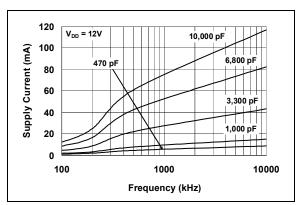


FIGURE 2-17: Supply Current vs. Frequency.

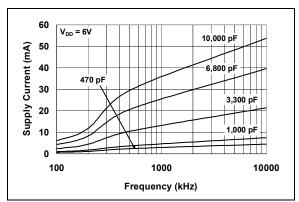


FIGURE 2-18: Supply Current vs. Frequency.

Typical Performance Curves (Continued)

Note: Unless otherwise indicated, $T_A = +25^{\circ}C$ with $4.5V \le V_{DD} \le = 18V$.

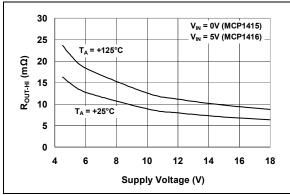


FIGURE 2-19: Output Resistance (Output High) vs. Supply Voltage.

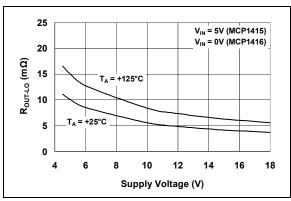


FIGURE 2-20: Output Resistance (Output Low) vs. Supply Voltage.

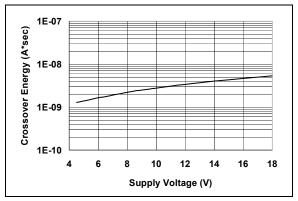


FIGURE 2-21: Crossover Energy vs. Supply Voltage.

3.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 3-1.

TABLE 3-1: PIN FUNCTION TABLE

SOT-23-5	Symbol	Description				
1	NC	No Connection				
2	V_{DD}	Supply Input				
3	IN	Control Input				
4	GND	Ground				
5	OUT	Output				

3.1 Supply Input (V_{DD})

 V_{DD} is the bias supply input for the MOSFET driver and has a voltage range of 4.5V to 18V. This input must be decoupled to ground with a local capacitor. This bypass capacitor provides a localized low impedance path for the peak currents that are to be provided to the load.

3.2 Control Input (IN)

The MOSFET driver input is a high impedance, TTL/CMOS compatible input. The input also has hysteresis between the high and low input levels, allowing them to be driven from a slow rising and falling signals, and to provide noise immunity.

3.3 Ground (GND)

Ground is the device return pin. The ground pin should have a low impedance connection to the bias supply source return. High peak currents will flow out the ground pin when the capacitive load is being discharged.

3.4 Output (OUT)

The output is a CMOS push-pull output that is capable of sourcing and sinking 1.5A of peak current ($V_{DD} = 18V$). The low output impedance ensures the gate of the external MOSFET will stay in the intended state even during large transients. This output also has a reverse current latch-up rating of 500 mA.

4.0 APPLICATION INFORMATION

4.1 General Information

MOSFET drivers are high-speed, high current devices which are intended to source/sink high peak currents to charge/discharge the gate capacitance of external MOSFETs or IGBTs. In high frequency switching power supplies, the PWM controller may not have the drive capability to directly drive the power MOSFET. A MOSFET driver like the MCP1415/16 family can be used to provide additional source/sink current capability.

4.2 MOSFET Driver Timing

The ability of a MOSFET driver to transition from a fully off state to a fully on state are characterized by the drivers rise time (t_R), fall time (t_F), and propagation delays (t_{D1} and t_{D2}). The MCP1415/16 family of drivers can typically charge and discharge a 1000 pF load capacitance in 20 ns along with a typical turn on (t_{D1}) propagation delay of 41 ns. Figure 4-1 and Figure 4-2 show the test circuit and timing waveform used to verify the MCP1415/16 timing.

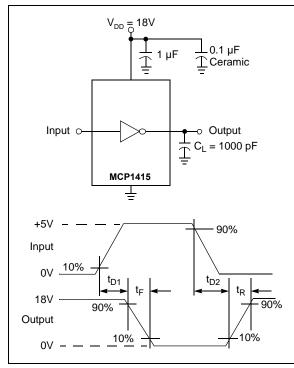


FIGURE 4-1: Inverting Driver Timing Waveform.

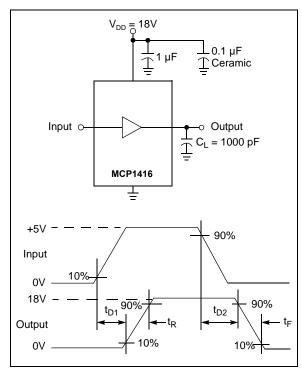


FIGURE 4-2: Non-Inverting Driver Timing Waveform.

4.3 Decoupling Capacitors

Careful layout and decoupling capacitors are required when using power MOSFET drivers. Large current are required to charge and discharge capacitive loads quickly. For example, approximately 720 mA are needed to charge a 1000 pF load with 18V in 25 ns.

To operate the MOSFET driver over a wide frequency range with low supply impedance, a ceramic and low ESR film capacitor is recommended to be placed in parallel between the driver V_{DD} and GND. A 1.0 μF low ESR film capacitor and a 0.1 μF ceramic capacitor placed between pins 2 and 4 is required for reliable operation. These capacitors should be placed close to the driver to minimize circuit board parasitics and provide a local source for the required current.

4.4 Power Dissipation

The total internal power dissipation in a MOSFET driver is the summation of three separate power dissipation elements.

EQUATION 4-1:

 $P_T = P_L + P_Q + P_{CC}$

Where:

P_T = Total power dissipation
 P_L = Load power dissipation
 P_Q = Quiescent power dissipation
 P_{CC} = Operating power dissipation

4.4.1 CAPACITIVE LOAD DISSIPATION

The power dissipation caused by a capacitive load is a direct function of the frequency, total capacitive load, and supply voltage. The power lost in the MOSFET driver for a complete charging and discharging cycle of a MOSFET is shown in Equation 4-2.

EQUATION 4-2:

 $P_L = f \times C_T \times V_{DD}^2$

Where:

f = Switching frequency $C_T = Total load capacitance$

V_{DD} = MOSFET driver supply voltage

4.4.2 QUIESCENT POWER DISSIPATION

The power dissipation associated with the quiescent current draw depends upon the state of the input pin. The MCP1415/16 devices have a quiescent current draw when the input is high of 0.65 mA (typical) and 0.1 mA (typical) when the input is low. The quiescent power dissipation is shown in Equation 4-3.

EQUATION 4-3:

 $P_{Q} = (I_{Q}H \times D + I_{Q}L \times (1 - D)) \times V_{DD}$ Where:

 I_{OH} = Quiescent current in the high

state

D = Duty cycle

I_{OI} = Quiescent current in the low

state

 V_{DD} = MOSFET driver supply voltage

4.4.3 OPERATING POWER DISSIPATION

The operating power dissipation occurs each time the MOSFET driver output transitions because for a very short period of time both MOSFETs in the output stage are on simultaneously. This cross-conduction current leads to a power dissipation describe in Equation 4-4.

EQUATION 4-4:

 $P_{CC} = CC \times f \times V_{DD}$

Where:

CC = Cross-conduction constant

(A*sec)

f = Switching frequency

 V_{DD} = MOSFET driver supply voltage

4.5 PCB Layout Considerations

Proper PCB layout is important in high current, fast switching circuits to provide proper device operation and robustness of design. Improper component placement may cause errant switching, excessive voltage ringing, or circuit latch-up. PCB trace loop area and inductance must be minimized. This is accomplished by placing the MOSFET driver directly at the load and placing the bypass capacitor directly at the MOSFET driver (Figure 4-3). Locating ground planes or ground return traces directly beneath the driver output signal also reduces trace inductance. A ground plane will also help as a radiated noise shield as well as providing some heat sinking for power dissipated within the device (Figure 4-4).

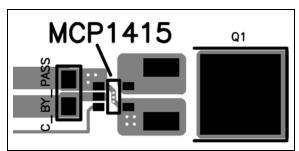


FIGURE 4-3: Recommended PCB Layout (TOP).

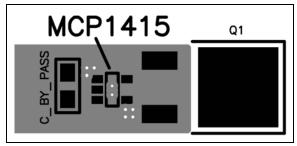


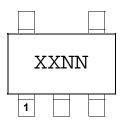
FIGURE 4-4: (BOTTOM).

Recommended PCB Layout

5.0 PACKAGING INFORMATION

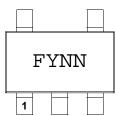
5.1 Package Marking Information

5-Lead SOT-23



Standard Markings for SOT-23					
Part Number Code					
MCP1415T-E/OT	FYNN				
MCP1416T-E/OT FZNN					





Legend: XX...X Customer-specific information Year code (last digit of calendar year)

YY Year code (last 2 digits of calendar year)
WW Week code (week of January 1 is week '01')

NNN Alphanumeric traceability code

e3 Pb-free JEDEC designator for Matte Tin (Sn)

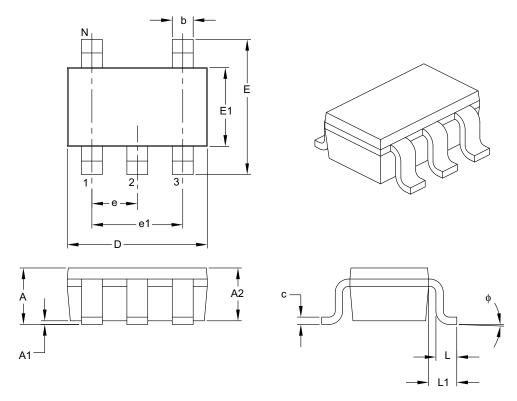
This package is Pb-free. The Pb-free JEDEC designator (e3

can be found on the outer packaging for this package.

Note: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line, thus limiting the number of available characters for customer-specific information.

5-Lead Plastic Small Outline Transistor (OT) [SOT-23]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units			MILLIMETERS			
Dimensi	MIN	NOM	MAX				
Number of Pins	N	5					
Lead Pitch	е		0.95 BSC				
Outside Lead Pitch	e1	1.90 BSC					
Overall Height	Α	0.90 – 1.45					
Molded Package Thickness	A2	0.89	_	1.30			
Standoff	A1	0.00	_	0.15			
Overall Width	E	2.20	_	3.20			
Molded Package Width	E1	1.30	_	1.80			
Overall Length	D	2.70	_	3.10			
Foot Length	L	0.10	_	0.60			
Footprint	L1	0.35	_	0.80			
Foot Angle	ф	0°	_	30°			
Lead Thickness	С	0.08	_	0.26			
Lead Width	b	0.20	-	0.51			

Notes:

- 1. Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.127 mm per side.
- 2. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing C04-091B

NOTES:

APPENDIX A: REVISION HISTORY

Revision B (June 2008)

The following is the list of modifications:

- DC Characteristics table, Switching Time, Rise Time: changed from 13 to 20.
- DC Characteristics table, Switching Time, Fall Time: changed from 13 to 20.
- 3. DC Characteristics (Over Operating Temperature Range) table, Switching Time, Rise Time: changed maximum from 35 to 40.
- 4. DC Characteristics (Over Operating Temperature Range) table, Switching Time, Rise Time: changed typical from 25 to 30.
- 5. DC Characteristics (Over Operating Temperature Range) table, Switching Time, Fall Time: changed maximum from 35 to 40.
- 6. DC Characteristics (Over Operating Temperature Range) table, Switching Time, Fall Time: changed typical from 25 to 30.

Revision A (June 2008)

· Original Release of this Document.

NOTES:

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, refer to the factory or the listed sales office.

* All package offerings are Pb Free (Lead Free)

PART NO. /XX Examples: MCP1415T-E/OT: 1.5A Inverting, **Device** Temperature Package MOSFET Driver Range 5LD SOT-23 Package Device: MCP1415T: 1.5A MOSFET Driver, Inverting MCP1416T-E/OT: 1.5A Non-Inverting, MOSFET Driver a) (Tape and Reel)
MCP1416T: 1.5A MOSFET Driver, Non-Inverting 5LD SOT-23 Package (Tape and Reel) Temperature Range: $E = -40^{\circ}C$ to $+125^{\circ}C$ Package: * OT = Plastic Thin Small Outline Transistor (OT), 5-Lead

NOTES:

Note the following details of the code protection feature on Microchip devices:

- · Microchip products meet the specification contained in their particular Microchip Data Sheet.
- Microchip believes that its family of products is one of the most secure families of its kind on the market today, when used in the
 intended manner and under normal conditions.
- There are dishonest and possibly illegal methods used to breach the code protection feature. All of these methods, to our knowledge, require using the Microchip products in a manner outside the operating specifications contained in Microchip's Data Sheets. Most likely, the person doing so is engaged in theft of intellectual property.
- Microchip is willing to work with the customer who is concerned about the integrity of their code.
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Corporate Office

2355 West Chandler Blvd. Chandler, AZ 85224-6199 Tel: 480-792-7200

Fax: 480-792-7277 Technical Support:

http://support.microchip.com

Web Address: www.microchip.com

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Asia Pacific Office

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